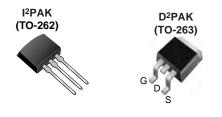


ROHS COMPLIANT

N-Channel 45-V (D-S) MOSFET

PRODUCT SUMMARY								
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, c}	Q _g (Typ.)					
45	0.0057 at V _{GS} = 10 V	75	240 nC					
45	0.0060 at V _{GS} = 4.5 V	70	240 110					

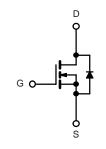


FEATURES

- TrenchFET[®] Power MOSFET
- 100 % R_g and UIS Tested

APPLICATIONS

- Synchronous Rectification
- Power Supplies



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	$T_A = 25 \ ^\circ C$, unle	ss otherwise n	noted	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	45	v	
Gate-Source Voltage	V _{GS}	± 25	V	
	T _C = 25 °C		75 ^{a, c}	
Continuous Drain Current (T ₁ = 175 °C)	T _C = 70 °C		70 ^c	
Continuous Drain Current $(T_j = T/5 C)$	T _A = 25 °C	I _D	29 ^b	A
	T _A = 70 °C		23 ^b	
Pulsed Drain Current	I _{DM}	250		
Avalanche Current Pulse		I _{AS}	80	
Single Pulse Avalanche Energy	L = 0.1 mm	E _{AS}	320	V
Continuous Source-Drain Diode Current	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	^		
Continuous Source-Drain Diode Current	T _A = 25 °C	'S	2.6 ^b	
	T _C = 25 °C		312 ^a	
Movimum Dower Discipation	T _C = 70 °C	PD	200	w
Maximum Power Dissipation	T _A = 25 °C	۲D	3.13 ^b	V
	T _A = 70 °C		2.0 ^b	7
Operating Junction and Storage Temperature Rar	T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS								
Parameter		Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^b	Steady State	R _{thJA}	32	40	°C/W			
Maximum Junction-to-Case	Steady State	R _{thJC}	0.33	0.4	C/W			

Notes:

a. Based on $T_C = 25$ °C.

b. Surface Mounted on 1" x 1" FR4 board.

c. Calculated based on maximum junction temperature. Package limitation current is 110 A.

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static	Gymbol			Typ.	max.	Onic
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 µA	40			V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J			41		mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J	I _D = 250 μΑ		- 8		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1.2		2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
	000	V _{DS} = 40 V, V _{GS} = 0 V			1	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 V, V_{GS} = 10 V$	120			A
		V _{GS} = 10 V, I _D = 30 A		0.0057		Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 20 A		0.0060		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 30 A		180		S
Dynamic ^b						
Input Capacitance	C _{iss}			18800		
Output Capacitance	C _{oss}	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz		1550		pF
Reverse Transfer Capacitance	C _{rss}			850		
Total Gate Charge	Q _g			240	360	nC
Gate-Source Charge	Q _{gs}	$V_{DS} = 20$ V, $V_{GS} = 10$ V, $I_{D} = 20$ A		40		
Gate-Drain Charge	Q _{gd}			22		
Gate Resistance	R _g	f = 1 MHz		0.85	1.3	Ω
Turn-On Delay Time	t _{d(on)}			20	30	-
Rise Time	t _r	$V_{DD} = 20 \text{ V}, \text{ R}_{L} = 1.0 \Omega$		11	17	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 20$ Å, $V_{GEN} = 10$ V, $R_g = 1$ Ω		77	115	
Fall Time	t _f			10	15	
Turn-On Delay Time	t _{d(on)}			102	155	ns
Rise Time	t _r	V_{DD} = 20 V, R_{L} = 1.0 Ω		62	95	-
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 20$ Å, V_{GEN} = 4.5 V, R_g = 1 Ω		180	270	
Fall Time	t _f			60	90	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			110	A
Pulse Diode Forward Current ^a	I _{SM}				200	
Body Diode Voltage	V _{SD}	I _S = 20 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			50	75	ns
Body Diode Reverse Recovery Charge	Q _{rr}	L = 20.4 di/dt = 100.4 ms = 25.90		70	105	nC
Reverse Recovery Fall Time	t _a	$I_F = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		30		
Reverse Recovery Rise Time	t _b			20		ns

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

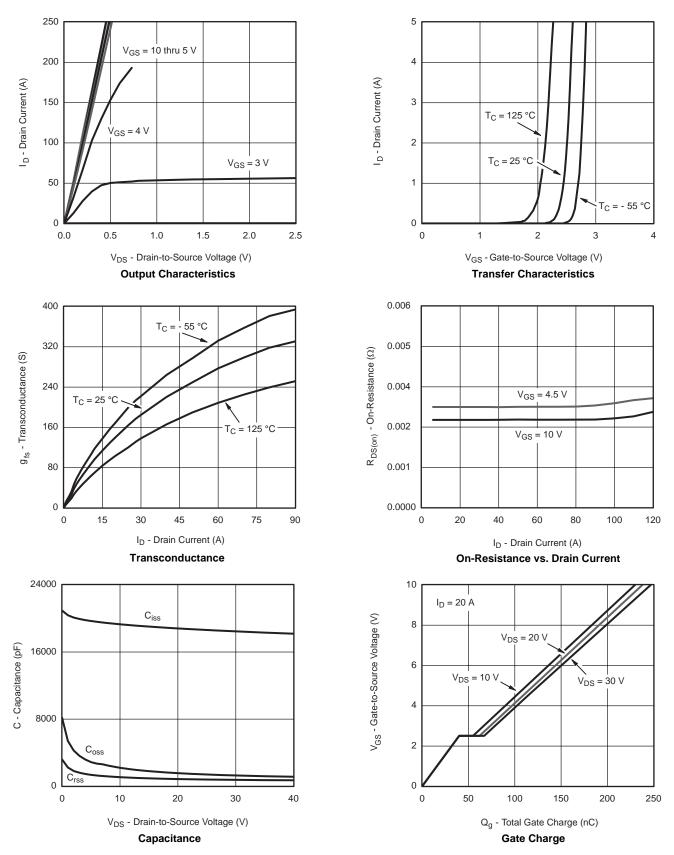
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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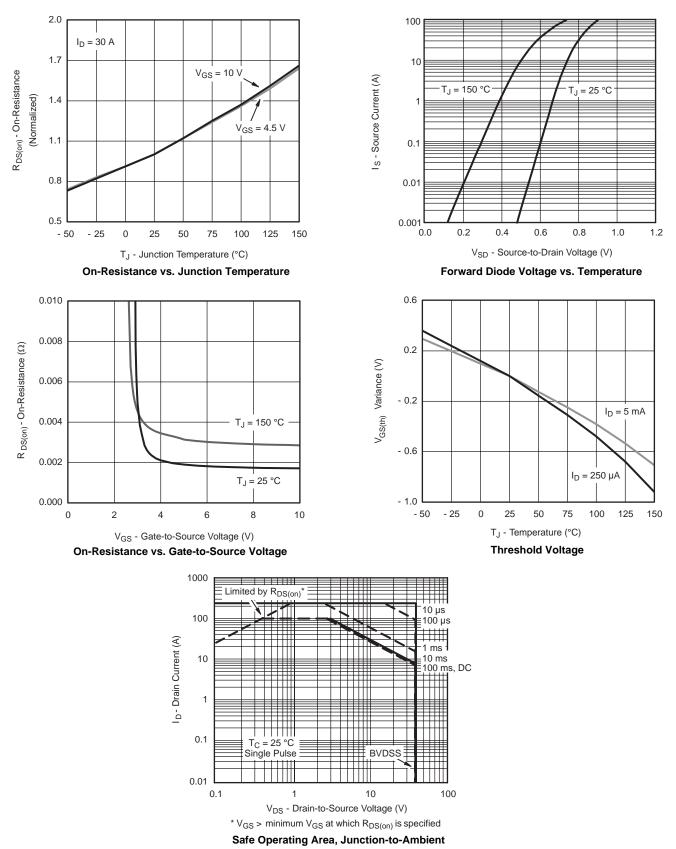
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



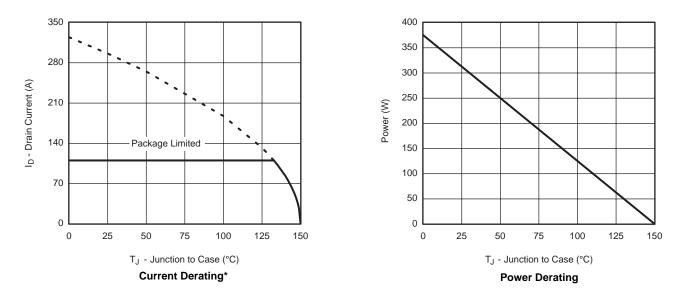
服务热线:400-655-8788



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

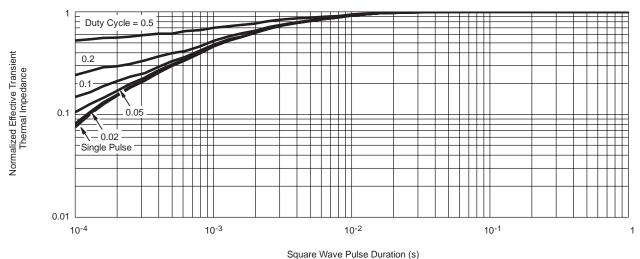






TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

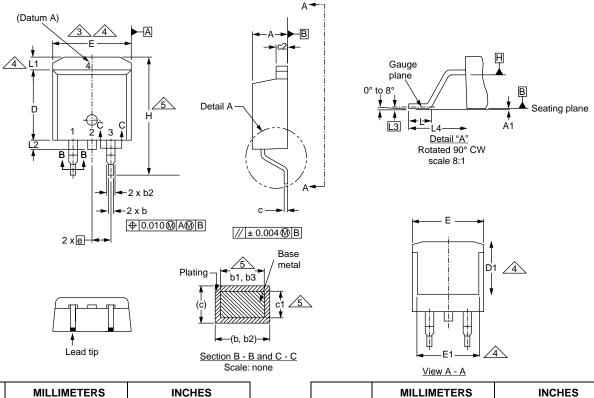
* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Normalized Thermal Transient Impedance, Junction-to-Case



TO-263AB (HIGH VOLTAGE)



	MILLIN	METERS	INC	HES			MILLIMETERS INCHES		HES	
DIM.	MIN.	MAX.	MIN.	MAX.		DIM.	MIN.	MAX.	MIN.	MAX.
А	4.06	4.83	0.160	0.190		D1	6.86	-	0.270	-
A1	0.00	0.25	0.000	0.010		Е	9.65	10.67	0.380	0.420
b	0.51	0.99	0.020	0.039		E1	6.22	-	0.245	-
b1	0.51	0.89	0.020	0.035		е	2.54 BSC		0.100 BSC	
b2	1.14	1.78	0.045	0.070		Н	14.61	15.88	0.575	0.625
b3	1.14	1.73	0.045	0.068		L	1.78	2.79	0.070	0.110
С	0.38	0.74	0.015	0.029		L1	-	1.65	-	0.066
c1	0.38	0.58	0.015	0.023		L2	-	1.78	-	0.070
c2	1.14	1.65	0.045	0.065		L3	0.25 BSC		0.010 BSC	
D	8.38	9.65	0.330	0.380		L4	4.78	5.28	0.188	0.208
ECN: S-82 DWG: 597	110-Rev. A, 0	15-Sep-08			•					

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Dimensions are shown in millimeters (inches).

3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.

4. Thermal PAD contour optional within dimension E, L1, D1 and E1.

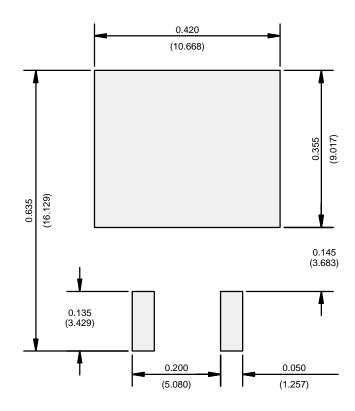
5. Dimension b1 and c1 apply to base metal only.

6. Datum A and B to be determined at datum plane H.

7. Outline conforms to JEDEC outline to TO-263AB.



RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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